

## SPECIFICATION AND PERFORMANCE

Series	209E-BE01	File	209E-BE01_SPEC_1	Date	2024/06/20
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### Scope:

This specification covers the requirements for product performance, test methods and quality assurance provisions of **209E-BE01**

### Performance and Descriptions:

The product is designed to meet the electrical, mechanical and environmental performance requirements specification. Unless otherwise specified, all tests are performed at ambient environmental conditions.

### RoHS:

All material in according with the RoHS environment related substances list controlled.

### MATERIALS

NO.	PART NAME	DESCRIPTION
1	HOUSING	LCP UL94V-0 Black
2	CONTACT	Phosphor bronze , Contact area: 15u" gold plating, Solder area: 100u" min. Tin plating, Under plated: 50u" min. Nickel plating over all
3	SHELL	Stainless steel, Nickel plating

### RATING

Current Rating	1.8A for Vconn & GND, 0.25A for other pin
Operating Temperature	-20°C to +85°C
Storage Temperature	-20°C to +85°C
Durability	10,000 cycles

### ELECTRICAL

Item	Requirement	Test Condition
Contact Resistance	Initial 30mΩ Max. for VBUS and GND, 50mΩ for all other pin.  After test Δ10mΩ Max.	Mate connectors, measure by dry circuit 20mV Max., 100mA Max. (EIA 364-23)
Dielectric Withstanding Voltage	100 VAC No flashover and breakdown	The object of this test procedure is to detail a test method to prove that a USB connector can operate safely at its rated voltage and withstand momentary over-potentials due to switching, surges, and/or other similar phenomena. (EIA 364-20)

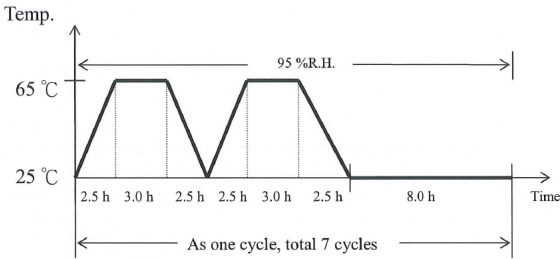


Insulation Resistance	100 MΩ (Min).	The object of this test procedure is to detail a standard method to assess the insulation resistance of USB connectors. This test procedure is used to determine the resistance offered by the insulation materials and the various seals of a connector to a DC potential tending to produce a leakage of current through or on the surface of these members. (EIA 364-21)
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MECHANICAL		
Item	Requirement	Test Condition
Mating force	35N (3.57kgf) Max.	Operation Speed : 12.5 ± 3 mm/minute Measure the force required to mate/unmate connector. (EIA-364-13)
Unmating force	10N (1.02kgf) Min.	Operation Speed : 12.5 ± 3 mm/minute Measure the force required to mate/unmate connector. (EIA-364-13)
Durability	No damage	Mate and unmate connector assemblies for 10,000 cycles at maximum rate of 200 cycles per hour. (EIA 364-09)
Vibration	No damage Discontinuity: <1us	Subject mated connectors to 10~55~10Hz traversed in 1 minute at 1.52mm amplitude 2 hours each of 3 mutually perpendicular planes (EIA 364-28)

ENVIRONMENTAL		
Item	Requirement	Test Condition
Thermal shock test	No Damage	Sample condition: mated -20°C, -15 minutes, +85°C, 15 minutes, 10 cycles. (EIA 364-32)
Temperature Life	No damage	Sample condition: mated Temperature: 105°C Duration: 120 hours



Humidity	No damage	<p>Sample condition: mated</p>  <p>(EIA 364-31)</p>
Salt mist test	No Damage	<p>8 hours exposure to a salt spray from the 5% solution at <math>35 \pm 2^{\circ}\text{C}</math> (MIL-STD-1344)</p>

SOLDER ABILITY		
Item	Requirement	Test Condition
Solder ability	95% area coverage min.	<p>Pre-condition: 8 hours steam aging Solder bath temperature: <math>255^{\circ}\text{C}</math> Speed: 25 mm/s Dip time: 5 seconds Solder: Sn/3.0Ag/0.5Cu Flux: RMA Type Method: DIP</p>
Resistance to soldering heat	No melting, cracks or functional damage allowed	<p>Preheating temperature: <math>80^{\circ}\text{C}</math>, 60 seconds Temperature: <math>260^{\circ}\text{C}</math> Immersion duration: 10 sec</p>